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Harrison, C.G.M.; Lam, K.W.;
VHDL (Very High Speed Integrated Circuits Hardware Description Language) - Applications and CAE Advances, IEE Colloquium on (Digest No.1993/076) , 6 Apr 1993
Page(s): 9/1 -9/3

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---

2 **Verification of VHDL designs using VAL**
Augustin, L.M.; Gennart, B.A.; Huh, Y.; Luckham, D.C.; Stanculescu, A.G.;
Design Automation Conference, 1988. Proceedings., 25th ACM/IEEE , 12-15 Jun 1988
Page(s): 48 -53

[Abstract]   [PDF Full-Text (476 KB)] **IEEE CNF**

---

3 **Mixed-mode simulation of compiled VHDL programs**
Acosta, R.D.; Smith, S.P.; Larson, J.;
Computer-Aided Design, 1989. ICCAD-89. Digest of Technical Papers., 1989 IEEE International Conference on , 5-9 Nov 1989
Page(s): 176 -179

[Abstract]   [PDF Full-Text (348 KB)] **IEEE CNF**

---

4 **Storage mechanism for VHDL intermediate form**
Poterie, B.;

Design Automation Conference, 1990. EDAC. Proceedings of the
European , 12-15 Mar 1990
Page(s): 506 -510

[Abstract]   [PDF Full-Text (332 KB)] **IEEE CNF**

5 **Experiences in testing and debugging the i960 MX VHDL model**
Powley, G.S., Jr.; DeGroat, J.E.;
VHDL International Users Forum. Spring Conference, 1994.
Proceedings of , 1-4 May 1994
Page(s): 130 -135

[Abstract]   [PDF Full-Text (416 KB)] **IEEE CNF**

6 **CAD of microsystems-a challenge for systems engineering**
Mueller-Glaser, K.D.;
Design Automation Conference, 1996, with EURO-VHDL '96 and
Exhibition, Proceedings EURO-DAC '96, European , 16-20 Sep 1996
Page(s): 280 -281

[Abstract]   [PDF Full-Text (244 KB)] **IEEE CNF**

7 **Advanced avionics system development: achieving systems superiority through design automation**
Peterson, G.D.; Hines, J.W.;
Aerospace Conference, 1998. Proceedings., IEEE , Volume: 1 , 21-28
Mar 1998
Page(s): 231 -238 vol.1

[Abstract]   [PDF Full-Text (780 KB)] **IEEE CNF**

8 **A goal tree based high-level test planning system for DSP real number models**
Lin, M.; Armstrong, J.R.; Gray, F.G.;
Test Conference, 1998. Proceedings. International , 18-23 Oct 1998
Page(s): 1000 -1009

[Abstract]   [PDF Full-Text (1824 KB)] **IEEE CNF**

9 **Designing a custom DSP circuit using VHDL**
Kumar, K.A.; Petrasko, B.;
Micro, IEEE , Volume: 10 Issue: 5 , Oct 1990
Page(s): 46 -53

[Abstract]   [PDF Full-Text (484 KB)] **IEEE JNL**

---

10 Comment on “Event suppression by optimizing VHDL programs”

Chang, K.C.;
Computer-Aided Design of Integrated Circuits and Systems, IEEE Transactions on , Volume: 18 Issue: 9 , Sep 1999
Page(s): 1400 -1401

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